

IBM Docket No. FIS920030423US1

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

pplication of:

Christopher P. Ausschnitt

Serial No.:

10/771,684

Date:

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Group Art Unit:

2851

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Title:

**Method of Patterning Process** 

Examiner:

**Kevin C. Gutierrez** 

Metrology Based on the Intrinsic Focus Offset

**DeLIO & PETERSON, LLC** 

121 Whitney Avenue

New Haven, CT 06510-1241

## LETTER TO OFFICIAL DRAFTSMAN

Mail Stop ISSUE FEE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Applicants are herewith submitting 7 Replacement sheets of Formal Drawings for the approval of the Draftsman.

Please charge the Assignee IBM Corporation Deposit Account No. **09-0458** for any fee related to the acceptance of the attached Formal Drawings. A duplicate copy of this letter is enclosed for that purpose.

Respectfully submitted,

BY:

Attorney: Peter W. Peterson Registration No. 31,867

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